## Notice of References Cited

Application/Control No.

10/643,081

Examiner

Tony Chuo

Applicant(s)/Patent Under
Reexamination
UEJIMA ET AL.

Art Unit
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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification.
*	Α	US-2002/0102453	08-2002	Suenaga et al.	429/37
*	В	US-2002/0187379	12-2002	Yasuo et al.	429/34
	С	US-		*	
	D	US-			
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	G	US-			
	Н	US-			
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	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 1107340	06-2001	Europe	Front et al	H01M8/02
*	0	EP 1100097	05-2001	.Europe	Mitsui et al	H01G9/028
	Р					
	Q					
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	Т					

## **NON-PATENT DOCUMENTS**

_	NOI-FATENT BOOMENTS						
*	133	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	V						
	w						
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